

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
369	59.23	8/23/2007 <i>update section</i> 5/26/07	VP <i>vp</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB) 369, 347 (text search only see search history printout).	5/29/2007	VP